Closed Ion Source Gas Analyzers

CIS100/200/300 — 100, 200 and 300 amu systems



- · 100, 200 and 300 amu systems
- 1 ppm detection
- 10 mTorr max. operating pressure
- 1 × 10⁻¹² Torr detection limit
- · RGA Windows software
- Field-replaceable electron multiplier and filament
- · RGA and CIS mode

SRS Closed Ion Source Gas Analyzers

With better than 1 ppm detection limit, direct sampling at mTorr pressure, and a user-friendly Windows software package, the CIS systems will satisfy your most demanding applications. On-line process monitoring and control, verification of process gas purity at the point of use, high-vacuum residual gas analysis, and process equipment leak checking are some of the areas where these systems will prove indispensable.

Compact Design

The probe consists of a quadrupole mass spectrometer with a CIS ionizer mounted inside a 2.75" Conflat® Tee. The control unit mounts directly on the probe's feedthrough flange and contains all the necessary electronics for operating the instrument. The side port of the CIS nipple provides a connection for the differential pumping system that keeps the quadrupole, filament and detector at high vacuum. The system can be connected directly to a process chamber through its standard CIS mounting flange (2.75" CF). All parts in the unit are self-aligning making servicing easy. You can clean and reassemble the probe, and replace the filament and electron multiplier in the field, without ever calling the factory.

Gold Plated Ionizer

The entire ionizer is made of gold-plated stainless steel. This reduces outgassing and background signals in the ionization region, improves long-term stability, and permits operation

Distribution in the UK & Ireland



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while exposed to reactive and corrosive gases. A tungsten filament is used, which resists corrosive and reactive gases



CIS gold plated ionizer

like WF₆ and silane, and leads to extended lifetime. The closed (gas tight) design of the ionizer prevents commonly interfering species from backstreaming into the ionization volume. This produces peaks free of spectral overlap.

A Choice of Detectors

The CIS series analyzers come standard with both a Faraday cup detector (10 ppm detection) and a continuous dynode electron multiplier (1 ppm detection). The software allows you to easily switch between detectors.



Continuous dynode electron multiplier

Versatility

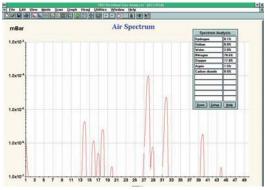
The CIS systems can also be used in a so-called "RGA mode". In this mode, the unit has a lower minimum detectable partial pressure, but a lower maximum operating pressure as well. The RGA mode is used, for example, in the first stage of a sputtering process when the chamber is evacuated to a low pressure, and the quality of the vacuum is checked for leaks and harmful contaminants. The unit can then be switched to a CIS mode for sampling directly at higher pressure.

Complete Programmability

A standard RS-232 interface is provided along with a complete programming reference. All probe parameters can be controlled and monitored, and data can be acquired for use in custom applications.

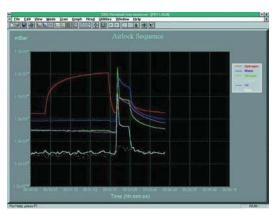
Windows Software

The CIS systems are supported with a real-time Windows software package that runs on PCs. The intuitive, graphical user interface allows measurements to be made quickly and easily. The program is fully interactive, giving the user complete control of the graphical display. Screens can be split for dual-mode operation, scales can be set to linear or log format, and data can be scaled manually or automatically. Data is captured and displayed in real time or scheduled for acquisition at a given interval for long-term data logging. Features include user-selectable units (ppm, Torr, mbar, Pa and A), programmable audio and visual alarms, and



RGA Windows software—Analog mode

comprehensive on-line help. The software allows complete CIS head control with easy mass scale tuning, sensitivity calibration, ionizer setup, and electron multiplier gain adjustment. For further analysis, data files can be saved in

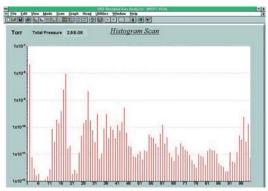


RGA Windows software—P vs. T mode



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ASCII format for easy transfer into spreadsheets. Graphic images can be saved as META files or copied to the clipboard



RGA Windows software—Histogram mode

for importing into other Windows programs. The software also provides password protection for locking out head parameters so that casual users can't alter important settings.

An optional stand-alone monitor (PPM100) can be used to control the RGA without a host computer.

Multi-Head Operation

The software supports multiple head operation when more than one CIS is needed. Up to eight ECUs can be monitored from the software.

Pumping Requirements

The CIS instruments require connection to a pumping system with an effective pumping speed of at least 40 L/s and a base pressure of less than 10^{-9} Torr. The connection port is a 2.75" CF flange. Option O100TDP provides a turbo pump

which mounts directly to the CIS head along with a diaphragm roughing pump. When this option is ordered, the entire analyzer is assembled, tested, and calibrated at the factory. Users can provide their own pumping station; however, it is the user's responsibility to ensure that the pumping system does not damage or limit the performance of the instrument.

Affordable Performance

The SRS CIS systems offer state-of-the-art performance for a fraction of the cost of competing models. Standard systems include faraday cup detector, electron multiplier detector and Windows software. Options include built-in power module for AC line operation, and a pumping package that includes a turbomolecular pump and diaphragm pump.

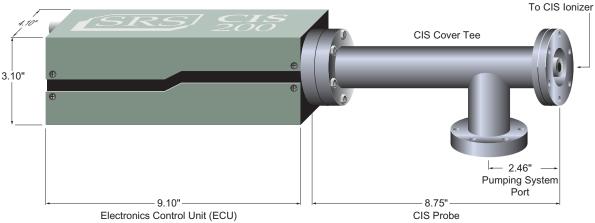




CIS rear panel (without AC power module)

CIS rear panel (with AC power module)

essure of less than 10⁻⁹ Torr. The connection port is a 75" CF flange. Option O100TDP provides a turbo pump



CIS dimensional drawing

CIS100/200/300 Specifications

Operational

Mass range

CIS100/1 1 to 100 amu CIS200/1 1 to 200 amu 1 to 300 amu CIS300/1 Mass filter type Quadrupole

Faraday cup and electron multiplier Detector type Resolution Better than 0.5 amu @ 10 % peak (per AVS std. 2.3) height. Adjustable to constant peak width throughout mass range.

70 °C (max.) Operating temperature 300 °C (without ECU)

Bakeout temperature

Warm-up time Peak height ± 2 % after 3 minutes.

Mass stability ± 0.1 amu after

30 minutes.

Computer interface RS-232C, 28,800 baud with high-

level command set

Software Windows based application 24 VDC @ 2.5 amps. Male DB9 Power

> connector, optional built-in power module for AC line operation

Weight 6 lbs.

Warranty One year parts and labor on defects

in materials and workmanship

lonizer

Design Closed ion source, cylindrical sym-

metry, electron impact ionization.

Material Gold plated SS304

Tungsten or ThO₂/Ir with firmware Filament

protection (field replaceable) 25 to 105 eV, programmable 4 or 8 eV, programmable 0 to 150 V, programmable 0 to 1 mA, programmable

Electron emission current

Electron energy

Focus voltage

Ion energy

General

Probe mounting flange 2.75" CF

 $4.1" \times 3.1" \times 9.1"$ (WHD). Easily ECU dimensions

separated from the probe for bakeout.

Probe dimensions See drawing

Power ON/OFF, filament ON/OFF, LED indicators Electron multiplier ON/OFF,

RS-232 Busy, Error, Overpressure,

Burnt Filament

Ordering Information

CIS100/1 100 amu CIS w/ electron multiplier CIS200/1 200 amu CIS w/ electron multiplier CIS300/1 300 amu CIS w/ electron multiplier

Option 02 AC power module O100HJC 200 °C heater jacket

O100EM Replacement electron multiplier O100RFT 2 replacement ThO₂/Ir filaments O100RFW 5 replacement tungsten filaments O100RIC

Replacement ionizer kit (includes filament)

O100TDP Turbo pump/diaphragm pump

| CIS Parameter | <u>Range</u> | CIS mode | RGA mode |
|---------------------------------|--------------|--------------------------------|-----------------|
| Electron emission current (mA) | 0 to 1 | 0.05 | 0.5 |
| Electron energy (eV) | 25 to 105 | 70 or 35 | 70 |
| Ion energy (eV) | 4 or 8 | 4 or 8 | 4 or 8 |
| Extraction voltage (V) | 0 to −150 | -50 (typ.) 10^{-6} | -50 (typ.) |
| Sensitivity (A/Torr) | | 10^{-6} | 10^{-5} |
| (for N ₂ @ 28 amu) | | | |
| Linear range upper limit (Torr) | | 2×10^{-3} | 10^{-4} |
| MDPP (Torr) | | 10^{-8} | 10^{-9} |

Notes

- 1. The CIS tests were performed with a 70 L/s hybrid turbomolecular pump, backed by a diaphragm pump, attached to the side port of the CIS Cover Tee.
- 2. The RGA mode sensitivities reported were calculated for N_2 at less than 10^{-5} Torr.
- 3. The CIS mode sensitivities were calculated for N_2 at 1 to 5×10^{-4} Torr.
- 4. MDPP (minimum detectable partial pressure) is determined by measuring baseline levels for Faraday cup detection in the presence of $^{28}N_2$ at 10^{-5} (RGA mode) and 10^{-3} Torr (CIS mode). Up to 3 orders of magnitude improvement in detectability is possible when the electron multiplier is turned on.





Closed vs. Open Ion Source Gas Analyzers

SRS RGAs use an Open Ion Source (OIS) configuration for ionization of gas molecules. The OIS extends into the process chamber and is "open" to all gaseous molecules in the vacuum environment. The pressure in the ionizer, mass filter, and ion detector is the same as the pressure in the vacuum chamber. The maximum operating pressure for an OIS analyzer is 10^{-4} Torr. However, the maximum pressure can be shifted up to about 10 Torr with the help of a pressure reducing gas inlet system (PPR). OIS analyzers have the sensitivity and dynamic range required to detect part-per-million (ppm) level contaminants. However, interferences from process gases and background outgassing from the sensor itself (i.e. the RGA) can make the detection of ppm levels of some common residual impurities, such as water, difficult.

In applications requiring the measurement of pressures between 10^{-4} and 10^{-2} Torr, the problem of background and process gas interferences with the mass spectra can be significantly reduced by replacing the traditional OIS PPR configuration with a Closed Ion Source (CIS) gas sampling system.

The CIS ionizer consists of a short, gas-tight tube with two small openings for the entrance of electrons and the exit of ions. Ions are produced by electron impact at the process pressure (mTorr range), while at the same time, a differential pumping system keeps the filament and the rest of the quadrupole assembly at pressures below 10^{-5} Torr (two decades lower).

Because the sampling pressure in the CIS is typically two decades higher than that of the rest of the sensor's vacuum system, the signal-to-background ratio is significantly increased relative to the OIS PPR configuration.

To illustrate the difference between the two ionization configurations, we use (as an example) the measurement of water impurity levels in a 10^{-3} Torr Ar sputtering process using both an OIS and a CIS gas analyzer.

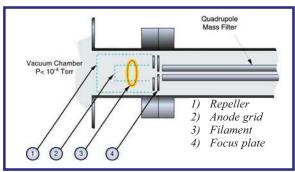
An OIS cannot be exposed directly to 1 mTorr of process pressure. A PPR must be used to step the total pressure down to about 10^{-5} Torr. The pressure drop brings a 1 ppm level of water in the process chamber (corresponding to a 10^{-9} Torr partial pressure of the impurity) to a partial pressure of about 10^{-11} Torr—well within the detection limit of a typical RGA. However, the residual pressure in the quadrupole is, at best, 10^{-9} Torr with most of that being water. This water background level is one hundred times larger than the 10^{-11} Torr corresponding to the 1 ppm of water coming from the process chamber. We conclude that water vapor in the process gas cannot be reliably measured to better than 100 ppm.

In the CIS system, the Ar gas is ionized directly at 10^{-3} Torr without any intermediate pressure reduction. At the same time, the background water signal is the same or less than in the OIS configuration, since it is due to water molecules

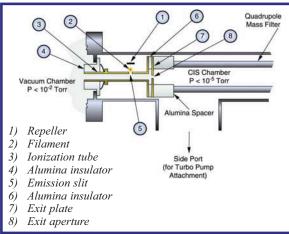
backstreaming into the CIS ionizer from the quadrupole assembly (approx. 10⁻⁹ Torr). This background water signal now corresponds to a 1 ppm water level in the process gas. The water vapor in the process gas can now be measured to better than 1 ppm (a two decade improvement).

The combination of direct sampling and differential pumping allows ppm and sub-ppm detection limits for even the most pervasive residual gases. For other common interferences, such as organic contaminants or reaction by-products of the filament, the gas-tight design of the source reduces the visibility of the ionization region to those gases, providing a very clean residual gas spectrum.

The ability of the CIS gas analyzer to sample in the mTorr range, and to provide ppm level detectability across its entire mass range, makes it ideal for semiconductor processing applications such as PVD, CVD and etching. However, the higher pressure limit of the CIS is achieved at the cost of an increased (two decades typical) minimum detectable partial pressure level relative to an OIS PPR.



Cross section of the SRS Open Ion Source (OIS)



Cross section of the SRS Closed Ion Source (CIS)